


<p style="text-align: center;">Search Notes</p> 	<p>Application/Control No.</p> <p>10563669</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>NAKAYOSHI ET AL.</p>
	<p>Examiner</p> <p>LUCY P CHIEN</p>	<p>Art Unit</p> <p>2871</p>

SEARCHED			
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SEARCH NOTES		
Search Notes	Date	Examiner
Please see attached search notes from EAST	6/25/2009	LC

INTERFERENCE SEARCH			
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/LUCY P CHIEN/
Examiner,Art Unit 2871